Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/895,057	JUTZI ET AL.	
Examiner	Art Unit	
Ellen C. Tran	2134	

	SEAR	CHED	
Class	Subclass	Date	Examiner
713	176	2/11/2007	ECT
726	27	2/11/2007	ECT
726	29	2/11/2007	ECT
713	164	2/11/2007	ECT

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES	2/11/2007	ECT
NPL - IEEE XPLORE	2/11/2007	ECT
All claims were reviewed for possible 101 rejection	2/11/2007	ECT